

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

**TC74LCX74F, TC74LCX74FN, TC74LCX74FT****Low-Voltage Dual D-Type Flip-Flop with 5-V Tolerant Inputs and Outputs**

The TC74LCX74F/FN/FT is a high-performance CMOS D-type flip-flop. Designed for use in 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (3.3 V) VCC applications, but it could be used to interface to 5-V supply environment for inputs.

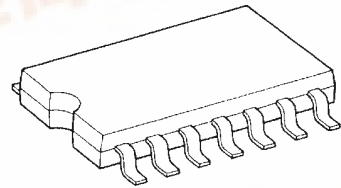
The signal level applied to the D input is transferred to Q output during the positive going transition of the CK pulse.  $\overline{\text{CLR}}$  and  $\overline{\text{PR}}$  are independent of the CK and are accomplished by setting the appropriate input low.

All inputs are equipped with protection circuits against static discharge.

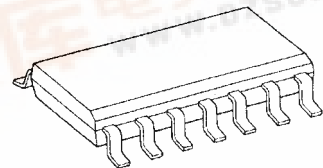
**Features**

- Low-voltage operation:  $V_{CC} = 2.0$  to  $3.6$  V
- High-speed operation:  $t_{pd} = 7.0$  ns (max) ( $V_{CC} = 3.0$  to  $3.6$  V)
- Output current:  $|I_{OH}|/I_{OL} = 24$  mA (min) ( $V_{CC} = 3.0$  V)
- Latch-up performance:  $\pm 500$  mA
- Available in JEDEC SOP, JEITA SOP and TSSOP
- Power-down protection provided on all inputs and outputs
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 74 type

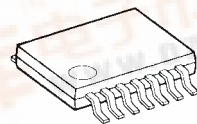
Note: xxxFN (JEDEC SOP) is not available in Japan.

**TC74LCX74F**

SOP14-P-300-1.27

**TC74LCX74FN**

SOL14-P-150-1.27

**TC74LCX74FT**

TSSOP14-P-0044-0.65

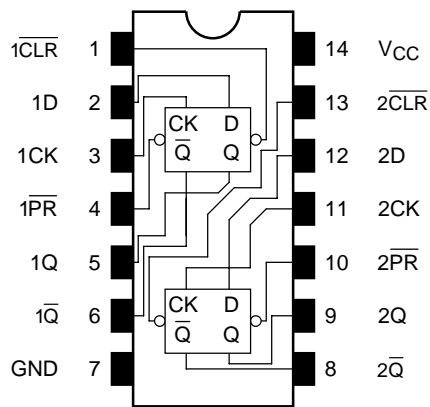
**Weight**

SOP14-P-300-1.27: 0.18 g (typ.)

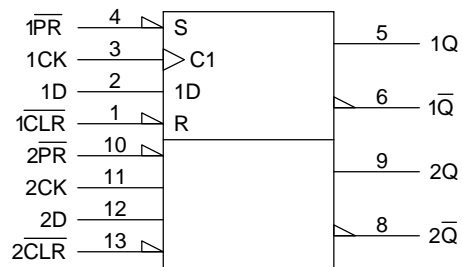
SOL14-P-150-1.27: 0.12 g (typ.)

TSSOP14-P-0044-0.65: 0.06 g (typ.)

Pin Assignment (top view)



IEC Logic Symbol



Truth Table

Inputs				Outputs		Function
CLR	PR	D	CK	Q	Q <sup>̄</sup>	
L	H	X	X	L	H	Clear
H	L	X	X	H	L	Preset
L	L	X	X	H	H	—
H	H	L	↑	L	H	—
H	H	H	↑	H	L	—
H	H	X	↓	Q <sub>n</sub>	Q <sub>n</sub> <sup>̄</sup>	No change

X: Don't care

Maximum Ratings

Characteristics	Symbol	Rating	Unit
Power supply voltage	V <sub>CC</sub>	−0.5 to 7.0	V
DC input voltage	V <sub>IN</sub>	−0.5 to 7.0	V
DC output voltage	V <sub>OUT</sub>	−0.5 to 7.0 (Note 1)	V
		−0.5 to V <sub>CC</sub> + 0.5 (Note 2)	
Input diode current	I <sub>IK</sub>	−50	mA
Output diode current	I <sub>OK</sub>	±50 (Note 3)	mA
DC output current	I <sub>OUT</sub>	±50	mA
Power dissipation	P <sub>D</sub>	180	mW
DC V <sub>CC</sub> /ground current	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA
Storage temperature	T <sub>stg</sub>	−65 to 150	°C

Note 1: V<sub>CC</sub> = 0 V

Note 2: High or low state. I<sub>OUT</sub> absolute maximum rating must be observed.

Note 3: V<sub>OUT</sub> < GND, V<sub>OUT</sub> > V<sub>CC</sub>

## Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	2.0 to 3.6	V
		1.5 to 3.6 (Note 4)	
Input voltage	$V_{IN}$	0 to 5.5	V
Output voltage	$V_{OUT}$	0 to 5.5 (Note 5)	V
		0 to $V_{CC}$ (Note 6)	
Output current	$I_{OH}/I_{OL}$	$\pm 24$ (Note 7)	mA
		$\pm 12$ (Note 8)	
Operating temperature	$T_{opr}$	-40 to 85	°C
Input rise and fall time	$dt/dv$	0 to 10 (Note 9)	ns/V

Note 4: Data retention only

Note 5:  $V_{CC} = 0$  V

Note 6: High or low state

Note 7:  $V_{CC} = 3.0$  to  $3.6$  VNote 8:  $V_{CC} = 2.7$  to  $3.0$  VNote 9:  $V_{IN} = 0.8$  to  $2.0$  V,  $V_{CC} = 3.0$  V

## Electrical Characteristics

DC Characteristics ( $T_a = -40$  to  $85^\circ\text{C}$ )

Characteristics		Symbol	Test Condition			Min	Max	Unit
					V <sub>CC</sub> (V)			
Input voltage	H-level	V <sub>IH</sub>	—		2.7 to 3.6	2.0	—	V
	L-level	V <sub>IL</sub>	—		2.7 to 3.6	—	0.8	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = −100 μA	2.7 to 3.6	V <sub>CC</sub> − 0.2	—	V
				I <sub>OH</sub> = −12 mA	2.7	2.2	—	
				I <sub>OH</sub> = −18 mA	3.0	2.4	—	
				I <sub>OH</sub> = −24 mA	3.0	2.2	—	
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.7 to 3.6	—	0.2	
				I <sub>OL</sub> = 12 mA	2.7	—	0.4	
				I <sub>OL</sub> = 16 mA	3.0	—	0.4	
				I <sub>OL</sub> = 24 mA	3.0	—	0.55	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 5.5 V	2.7 to 3.6	—	±5.0	μA	
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> /V <sub>OUT</sub> = 5.5 V	0	—	10.0	μA	
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	2.7 to 3.6	—	10.0	μA	
			V <sub>IN</sub> = 3.6 to 5.5 V	2.7 to 3.6	—	±10.0		
Increase in I <sub>CC</sub> per input		ΔI <sub>CC</sub>	V <sub>IH</sub> = V <sub>CC</sub> − 0.6 V	2.7 to 3.6	—	500		

## AC Characteristics (Ta = -40 to 85°C)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Maximum clock frequency	f <sub>max</sub>	Figure 1, Figure 2	2.7	—	—	MHz
			3.3 ± 0.3	150	—	
Propagation delay time (CK-Q, $\bar{Q}$ )	t <sub>pLH</sub> t <sub>pHL</sub>	Figure 1, Figure 2	2.7	—	8.0	ns
			3.3 ± 0.3	1.5	7.0	
Propagation delay time ( $\bar{CLR}$ , $\bar{PR}$ -Q, $\bar{Q}$ )	t <sub>pLH</sub> t <sub>pHL</sub>	Figure 1, Figure 4	2.7	—	8.0	ns
			3.3 ± 0.3	1.5	7.0	
Minimum pulse width (CK)	t <sub>W</sub> (H) t <sub>W</sub> (L)	Figure 1, Figure 2	2.7	3.3	—	ns
			3.3 ± 0.3	3.3	—	
Minimum pulse width ( $\bar{CLR}$ , $\bar{PR}$ )	t <sub>W</sub> (L)	Figure 1, Figure 4	2.7	3.6	—	ns
			3.3 ± 0.3	3.3	—	
Minimum setup time	t <sub>s</sub>	Figure 1, Figure 2	2.7	2.5	—	ns
			3.3 ± 0.3	2.5	—	
Minimum hold time	t <sub>h</sub>	Figure 1, Figure 2	2.7	1.5	—	ns
			3.3 ± 0.3	1.5	—	
Minimum removal time	t <sub>rem</sub>	Figure 1, Figure 3	2.7	3.0	—	ns
			3.3 ± 0.3	2.5	—	
Output to output skew	t <sub>osLH</sub> t <sub>osHL</sub>	(Note 10)	2.7	—	—	ns
			3.3 ± 0.3	—	1.0	

Note 10: Parameter guaranteed by design.

(t<sub>osLH</sub> = |t<sub>pLHm</sub> - t<sub>pLHn</sub>|, t<sub>osHL</sub> = |t<sub>pHLm</sub> - t<sub>pHLn</sub>|)

## Dynamic Switching Characteristics

(Ta = 25°C, input: t<sub>r</sub> = t<sub>f</sub> = 2.5 ns, C<sub>L</sub> = 50 pF, R<sub>L</sub> = 500 Ω)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Typ.	Unit
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	3.3	0.8	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	3.3	0.8	V

## Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Typ.	Unit
Input capacitance	C <sub>IN</sub>	—	3.3	7	pF
Output capacitance	C <sub>OUT</sub>	—	0	8	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz (Note 11)	3.3	25	pF

Note 11: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 \text{ (per bit)}$$

AC Test Circuit

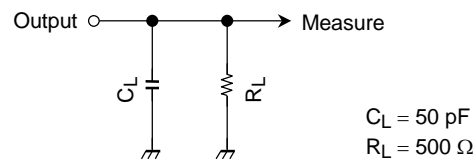


Figure 1

AC Waveform

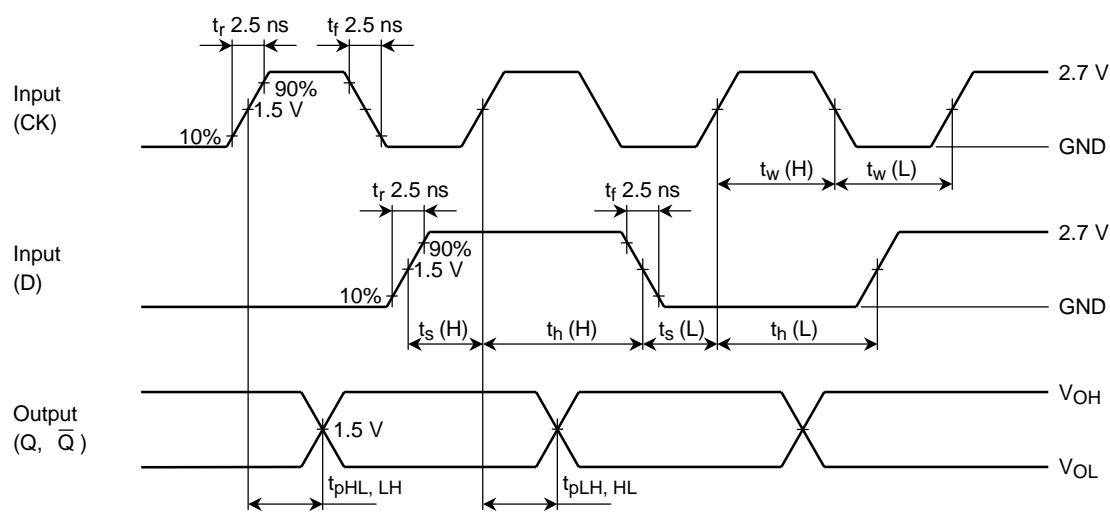


Figure 2  $t_{PLH}$ ,  $t_{PHL}$ ,  $t_w$ ,  $t_s$ ,  $t_h$

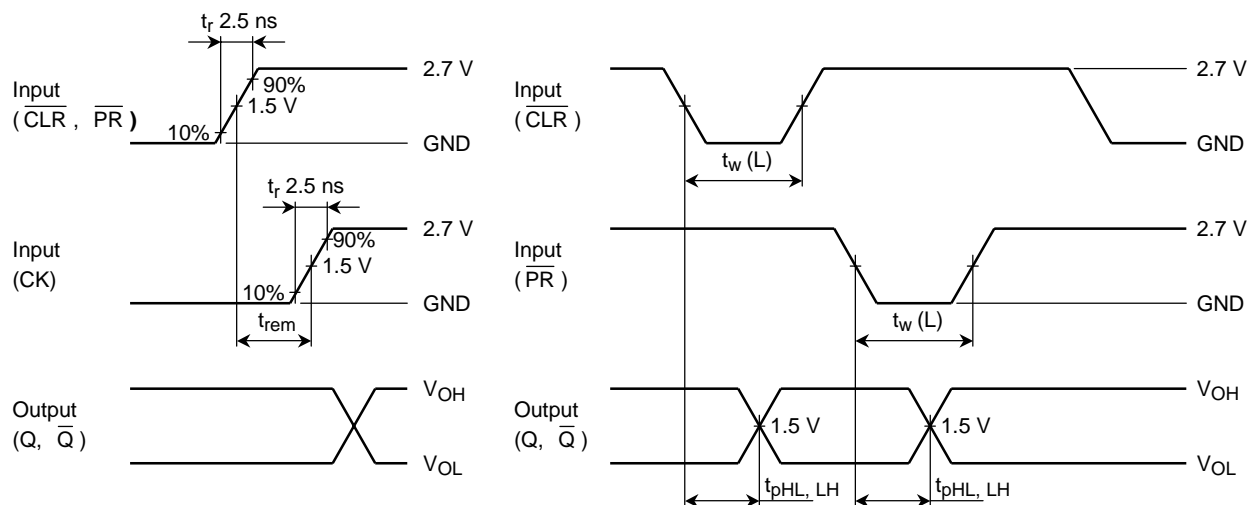
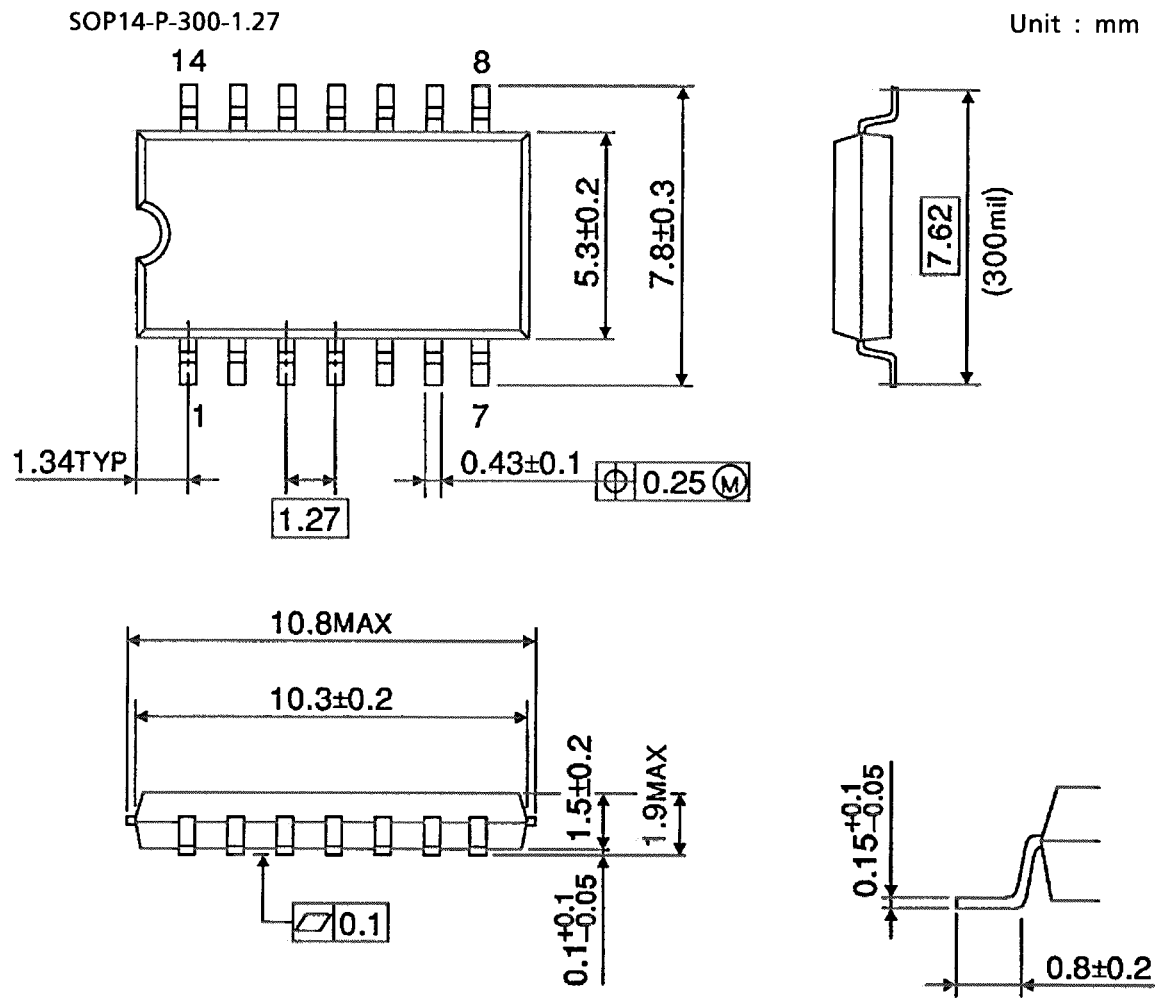


Figure 3  $t_{rem}$

Figure 4  $t_{PLH}$ ,  $t_{PHL}$

Package Dimensions



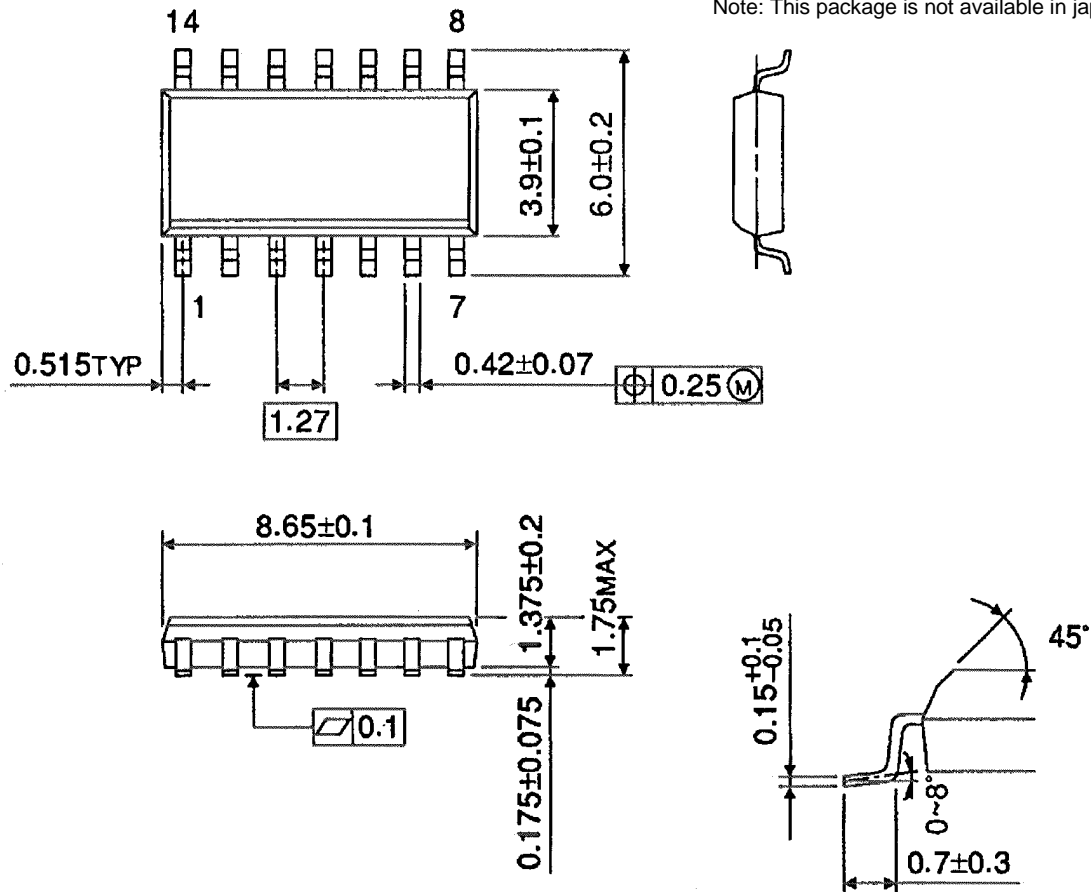
Weight: 0.18 g (typ.)

Package Dimensions

SOL14-P-150-1.27

Unit : mm

Note: This package is not available in japan.

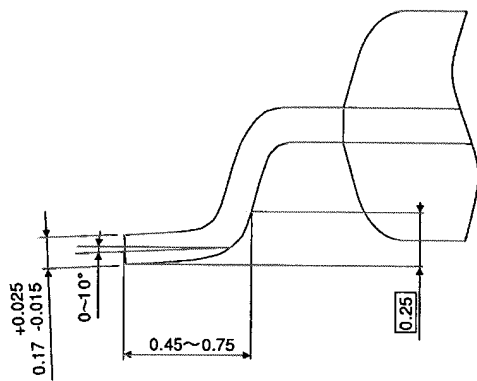
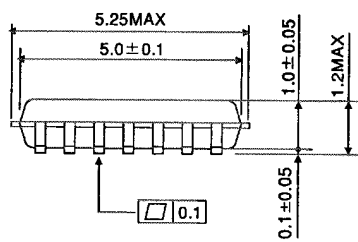
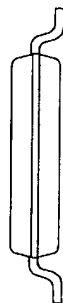
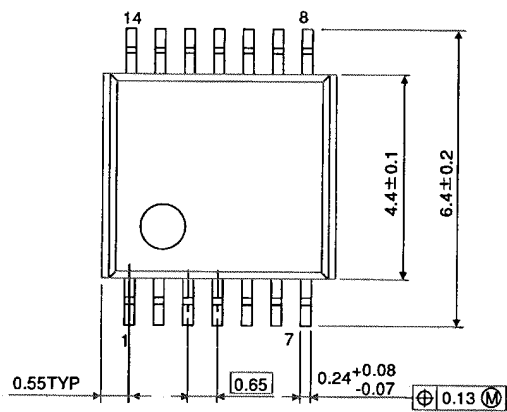


Weight: 0.12 g (typ.)

Package Dimensions

TSSOP14-P-0044-0.65

Unit : mm



Weight: 0.06 g (typ.)



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